

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/781,033	LEE
	Examiner	Art Unit
	John C. Hong	3726

SEARCHED			
Class	Subclass	Date	Examiner
29	525 428	6/27/55	Xh
	400		
464	162		
	167		
	178		
384	29, 42		
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358	474		
	497		
349	107		
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359	198-200		